

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,814	SHIMIZU ET AL.	SHIMIZU ET AL
Examiner	Art Unit	Art Unit
Longbit Chai	2131	2131

SEARCHED							
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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